

Search Notes

Application/Control No.

10/729,916

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

UETA ET AL.

Art Unit

1742

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR